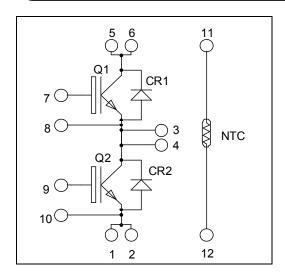
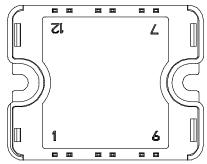


# Phase leg High speed Trench + Field Stop IGBT4 Power Module

$$V_{CES} = 650V$$
  
 $I_{C} = 100A$  @  $Tc = 60^{\circ}C$ 





Pins 3/4 must be shorted together

#### **Application**

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

#### **Features**

- High speed Trench + Field Stop IGBT 4
  - Low voltage drop
  - Low leakage current
  - Low switching losses
- Very low stray inductance
- Internal thermistor for temperature monitoring

#### **Benefits**

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS compliant

#### All ratings @ $T_i = 25^{\circ}C$ unless otherwise specified

#### Absolute maximum ratings (per IGBT)

Symbol	Parameter		Max ratings	Unit
$V_{CES}$	Collector - Emitter Voltage		650	V
T	Continuous Collector Current	$T_C = 25^{\circ}C$	135	
$I_{C}$		$T_C = 60$ °C	100	Α
$I_{CM}$	Pulsed Collector Current	$T_C = 25^{\circ}C$	270	
$V_{GE}$	Gate – Emitter Voltage		±20	V
$P_{D}$	Power Dissipation		350	W

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.



## **Electrical Characteristics** (per IGBT)

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit	
$I_{CES}$	Zero Gate Voltage Collector Current	$V_{GE} = 0V, V_{CE} = 650V$				50	μΑ
V <sub>CE(sat)</sub>	Collector Emitter Saturation Voltage	$V_{GE} = 15V$	$T_j = 25^{\circ}C$	1.4	1.85	2.3	V
		$I_C = 100A$ $T_j = 150$ °C	$T_{j} = 150^{\circ}C$		2.2		V
$V_{GE(th)}$	Gate Threshold Voltage	$V_{GE} = V_{CE}$ , $I_C = 1.6 \text{ mA}$		4.2	5.1	5.6	V
$I_{GES}$	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE} = 0V$				150	nA

**Dynamic Characteristics** (per IGBT)

Symbol	Characteristic	Test Condition	ıs	Min	Тур	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V$			6100		
$C_{oes}$	Output Capacitance	$V_{CE} = 25V$	$V_{CE} = 25V$		232		pF
$C_{res}$	Reverse Transfer Capacitance	f = 1MHz			180		
$Q_{G}$	Gate charge	$V_{GE} = 15V, I_{C} = 100A$ $V_{CE} = 480V$			630		nC
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (25°C)			19		
$T_{r}$	Rise Time	$V_{GE} = \pm 15V$			33		ns
T <sub>d(off)</sub>	Turn-off Delay Time	$V_{Bus} = 400V$ $I_{C} = 100A$			197		
$T_{\rm f}$	Fall Time	$R_G = 3.6\Omega$			21		İ
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (150°C)			19		
$T_{\rm r}$	Rise Time	$V_{GE} = \pm 15V$			29		
$T_{d(off)}$	Turn-off Delay Time	$V_{\text{Bus}} = 400V$ $I_{\text{C}} = 100A$ $R_{\text{G}} = 3.6\Omega$			227		ns
$T_{\mathrm{f}}$	Fall Time				22		
Eon	Turn on Energy	$V_{GE} = \pm 15V$ $V_{Bus} = 400V$	$T_j = 150$ °C		2.4		mJ
$E_{\text{off}}$	Turn off Energy	$I_C = 100A$ $R_G = 3.6\Omega$ $T_j = 150^{\circ}C$			2		111.J
$R_G$	Integrated gate resistor				2		Ω
$I_{sc}$	Short Circuit data	$V_{GE} \le 15V ; V_{Bus} = 400V$ $t_p \le 5\mu s ; T_j = 150^{\circ}C$			700		A
$R_{thJC}$	Junction to Case Thermal Resistance					0.44	°C/W

#### Diode ratings and characteristics (per diode)

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
$V_{RRM}$	Peak Repetitive Reverse Voltage					650	V
$I_{RM}$	Reverse Leakage Current	$V_R = 650V$				50	μΑ
$I_F$	DC Forward Current		$Tc = 25^{\circ}C$		100		A
$V_{\mathrm{F}}$	Diode Forward Voltage	$I_F = 100A$ $V_{GE} = 0V$	$T_i = 25^{\circ}C$ $T_i = 150^{\circ}C$		1.6	2	V
$t_{rr}$	Reverse Recovery Time	$I_F = 100A$ $V_R = 300V$ $di/dt = 2000A/\mu s$	$T_j = 25^{\circ}C$ $T_i = 150^{\circ}C$		125 220		ns
Q <sub>rr</sub>	Reverse Recovery Charge		$T_{j} = 25^{\circ}C$ $T_{i} = 150^{\circ}C$		4.7		μС
E <sub>rr</sub>	Reverse Recovery Energy	_ u/ut 2000Α/μs	$T_{j} = 25^{\circ}C$ $T_{i} = 150^{\circ}C$		1.1		mJ
$R_{thJC}$	Junction to Case Thermal Resistance	•	· ·			0.77	°C/W



#### Temperature sensor NTC (see application note APT0406 on www.microsemi.com).

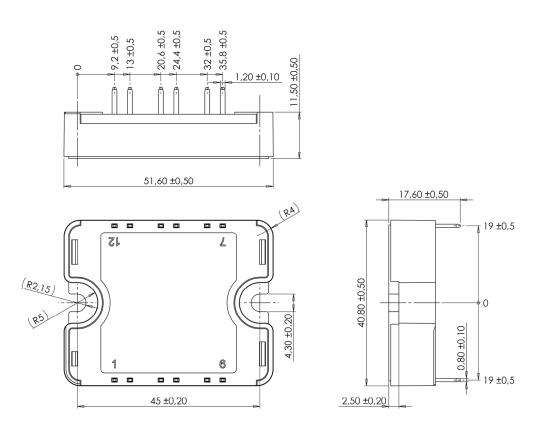
Symbol	Characteristic		Min	Тур	Max	Unit
R <sub>25</sub>	Resistance @ 25°C			50		kΩ
$\Delta R_{25}/R_{25}$				5		%
$B_{25/85}$	$T_{25} = 298.15 \text{ K}$			3952		K
$\Delta \mathrm{B/B}$		$T_{\rm C} = 100^{\circ}{\rm C}$		4		%

$$R_T = \frac{R_{25}}{\exp \left[ B_{25/85} \left( \frac{1}{T_{25}} - \frac{1}{T} \right) \right]} \quad \text{T: Thermistor temperature}$$
 R<sub>T</sub>: Thermistor value at T

#### Thermal and package characteristics

Symbol	Characteristic			Min	Max	Unit
$V_{ISOL}$	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000		V
$T_{J}$	Operating junction temperature range			-40	175	
$T_{JOP}$	Recommended junction temperature under sw	witching condit	ions	-40	T <sub>J</sub> max -25	°C
$T_{STG}$	Storage Temperature Range			-40	125	
$T_{\rm C}$	Operating Case Temperature			-40	125	
Torque	Mounting torque	To heatsink	M4	2	3	N.m
Wt	Package Weight				80	g

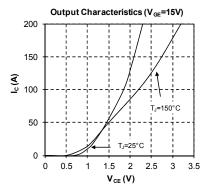
#### Package outline (dimensions in mm)

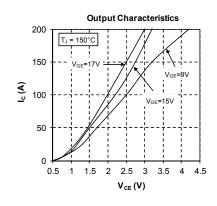


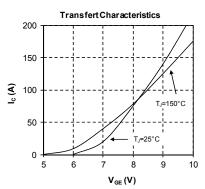
See application note 1904 - Mounting Instructions for SP1 Power Modules on www.microsemi.com

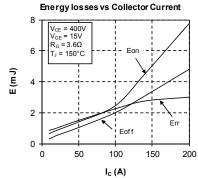


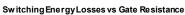
#### Typical performance curve

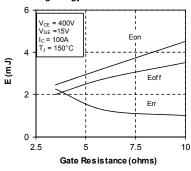












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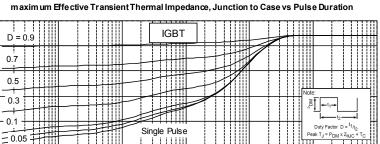
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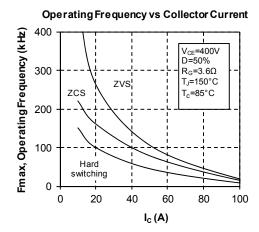
Thermallmpedance (°C/W)

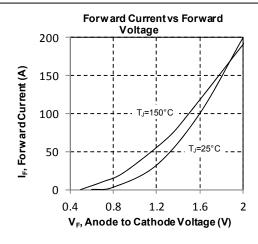


Rectangular Pulse Duration in Seconds

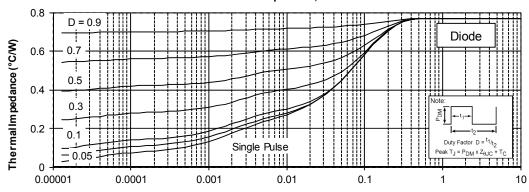


#### Fower Matters.





#### maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration



Rectangular Pulse Duration in Seconds



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